


## Insulated Gate Bipolar Transistor (Warp 2 Speed IGBT), 100 A


**SOT-227**
**FEATURES**

- Ultrafast: Optimized for minimum saturation voltage and speed 0 to 40 kHz in hard switching, > 200 kHz in resonant mode
- Very low conduction and switching losses
- Fully isolated package (2500 V AC/RMS)
- Very low internal inductance ( $\leq 5$  nH typical)
- Industry standard outline
- UL approved file E78996 
- Compliant to RoHS directive 2002/95/EC
- Designed and qualified for industrial market


**RoHS  
COMPLIANT**
**PRODUCT SUMMARY**

$V_{CES}$	600 V
$I_C$ DC	100 A
$V_{CE(on)}$ at 100 A, 25 °C	1.8 V

**BENEFITS**

- Designed for increased operating efficiency in power conversion: PFC, UPS, SMPS, welding, induction heating
- Lower overall losses available at frequencies  $\geq 20$  kHz
- Easy to assemble and parallel
- Direct mounting to heatsink
- Lower EMI, requires less snubbing
- Plug in compatible with other SOT-227 packages

**ABSOLUTE MAXIMUM RATINGS**

PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS
Collector to emitter breakdown voltage	$V_{CES}$		600	V
Continuous collector current	$I_C$	$T_C = 25\text{ °C}$	100	A
		$T_C = 100\text{ °C}$	50	
Pulsed collector current	$I_{CM}$		200	
Clamped inductive load current	$I_{LM}$	Repetitive rating: $V_{GE} = 20$ V; pulse width limited by maximum junction temperature (fig. 20)	200	
Gate to emitter voltage	$V_{GE}$		$\pm 20$	V
RMS isolation voltage	$V_{ISOL}$	Any terminal to case, $t = 1$ minute	2500	
Maximum power dissipation	$P_D$	$T_C = 25\text{ °C}$	250	W
		$T_C = 100\text{ °C}$	100	
Operating junction and storage temperature range	$T_J, T_{Stg}$		- 55 to + 150	°C
Mounting torque		6 to 32 or M3 screw	12 (1.3)	lbf · in (N · m)

**THERMAL AND MECHANICAL SPECIFICATIONS**

PARAMETER	SYMBOL	TYP.	MAX.	UNITS
Junction to case, IGBT	$R_{thJC}$	-	0.50	°C/W
Thermal resistance, junction to case, diode	$R_{thJC}$	-	1.0	
Case to sink, flat, greased surface	$R_{thCS}$	0.05	-	
Weight of module		30	-	g



<b>ELECTRICAL SPECIFICATIONS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0\text{ V}, I_C = 250\text{ }\mu\text{A}$ $V_{GE} = 0\text{ V}, I_C = 1.0\text{ mA}$	600	-	-	V	
Temperature coefficient of breakdown voltage	$\Delta V_{(BR)CES}/\Delta T_J$		-	0.36	-	V/ $^\circ\text{C}$	
Collector to emitter saturation voltage	$V_{CE(on)}$	$V_{GE} = 15\text{ V}, I_C = 50\text{ A}$	See fig. 1, 4	-	1.49	2.1	V
		$V_{GE} = 15\text{ V}, I_C = 100\text{ A}$		-	1.80	-	
		$V_{GE} = 15\text{ V}, I_C = 50\text{ A}, T_J = 150\text{ }^\circ\text{C}$		-	1.47	-	
Gate threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}, I_C = 250\text{ }\mu\text{A}$	3.0	-	6.0		
Temperature coefficient of threshold voltage	$\Delta V_{GE(th)}/\Delta T_J$	$V_{CE} = V_{GE}, I_C = 250\text{ }\mu\text{A}$	-	-7.6	-	mV/ $^\circ\text{C}$	
Forward transconductance	$g_{fe}$	$V_{CE} = 100\text{ V}, I_C = 50\text{ A}$	34	52	-	S	
Zero gate voltage collector current	$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = 600\text{ V}$	-	-	250	$\mu\text{A}$	
		$V_{GE} = 0\text{ V}, V_{CE} = 600\text{ V}, T_J = 150\text{ }^\circ\text{C}$	-	-	1.3	mA	
Diode forward voltage drop	$V_{FM}$	$I_C = 50\text{ A}$	See fig. 12	-	1.3	1.6	V
		$I_C = 50\text{ A}, T_J = 150\text{ }^\circ\text{C}$		-	1.16	1.3	
Gate to emitter leakage current	$I_{GES}$	$V_{GE} = \pm 20\text{ V}$	-	-	$\pm 100$	nA	

<b>SWITCHING CHARACTERISTICS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified)								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS		
Total gate charge (turn-on)	$Q_g$	$I_C = 50\text{ A}$ $V_{CC} = 400\text{ V}$ $V_{GE} = 15\text{ V}$	See fig. 7	-	430	640	nC	
Gate emitter charge (turn-on)	$Q_{ge}$			-	48	72		
Gate collector charge (turn-on)	$Q_{gc}$			-	130	190		
Turn-on delay time	$t_{d(on)}$	$T_J = 25\text{ }^\circ\text{C}$ $I_C = 60\text{ A}, V_{CC} = 480\text{ V}$ $V_{GE} = 15\text{ V}, R_g = 5.0\text{ }\Omega$ energy losses include "tail" and diode reverse recovery		-	57	-	ns	
Rise time	$t_r$			-	80	-		
Turn-off delay time	$t_{d(off)}$			-	240	-		
Fall time	$t_f$			-	120	-		
Turn-on switching loss	$E_{on}$			-	-	0.41	-	mJ
Turn-off switching loss	$E_{off}$							
Total switching loss	$E_{ts}$					2.92	4.4	
Turn-on delay time	$t_{d(on)}$	$T_J = 150\text{ }^\circ\text{C}$ $I_C = 60\text{ A}, V_{CC} = 480\text{ V}$ $V_{GE} = 15\text{ V}, R_g = 5.0\text{ }\Omega$ energy losses include "tail" and diode reverse recovery		-	57	-	ns	
Rise time	$t_r$			-	80	-		
Turn-off delay time	$t_{d(off)}$			-	380	-		
Fall time	$t_f$			-	170	-		
Total switching loss	$E_{ts}$			-	4.78	-	mJ	
Internal emitter inductance	$L_E$			-	2.0	-	nH	
Input capacitance	$C_{ies}$			$V_{GE} = 0\text{ V}$ $V_{CC} = 30\text{ V}$ $f = 1.0\text{ MHz}$	See fig. 6	-	7400	-
Output capacitance	$C_{oes}$	-	730			-		
Reverse transfer capacitance	$C_{res}$	-	90			-		
Diode reverse recovery time	$t_{rr}$	$T_J = 25\text{ }^\circ\text{C}$	See fig. 13		-	90	140	ns
		$T_J = 125\text{ }^\circ\text{C}$			-	120	180	
Diode peak reverse recovery current	$I_{rr}$	$T_J = 25\text{ }^\circ\text{C}$	See fig. 14		-	7.3	11	A
		$T_J = 125\text{ }^\circ\text{C}$			-	11	16	
Diode reverse recovery charge	$Q_{rr}$	$T_J = 25\text{ }^\circ\text{C}$	See fig. 15		-	360	550	nC
		$T_J = 125\text{ }^\circ\text{C}$			-	780	1200	
Diode peak rate of fall recovery during $t_b$	$dl_{(rec)M}/dt$	$T_J = 25\text{ }^\circ\text{C}$	See fig. 16		-	370	-	A/ $\mu\text{s}$
		$T_J = 125\text{ }^\circ\text{C}$			-	220	-	

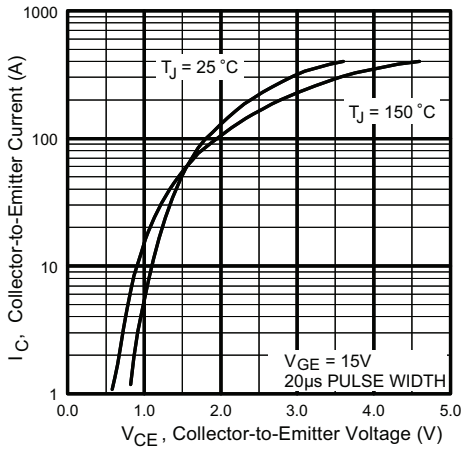


Fig. 1 - Typical Output Characteristics

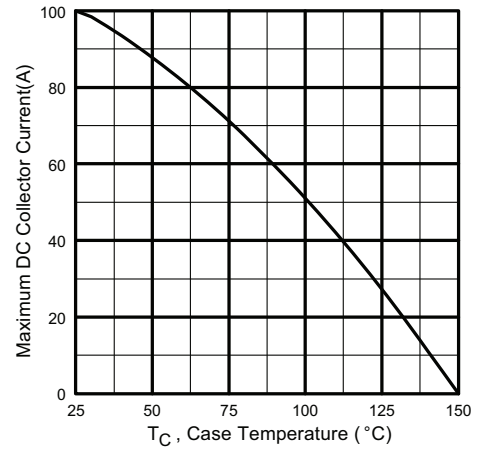


Fig. 3 - Maximum Collector Current vs. Case Temperature

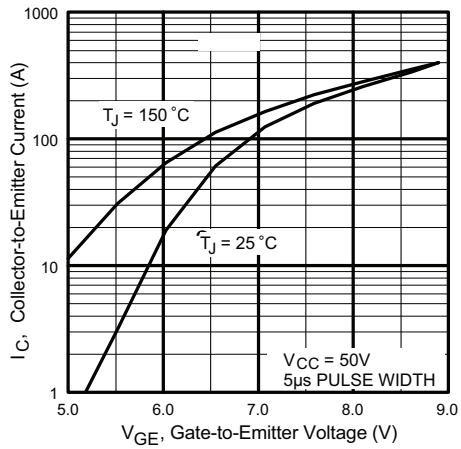


Fig. 2 - Typical Transfer Characteristics

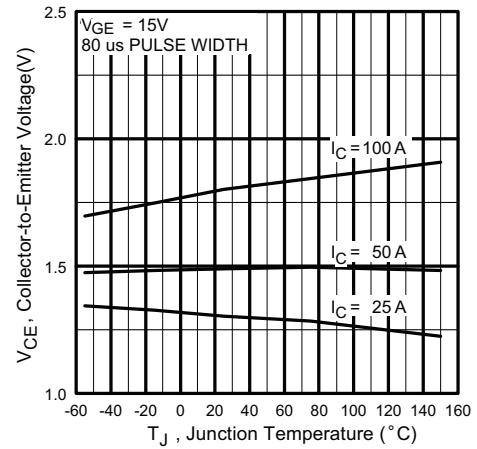


Fig. 4 - Typical Collector to Emitter Voltage vs. Junction Temperature

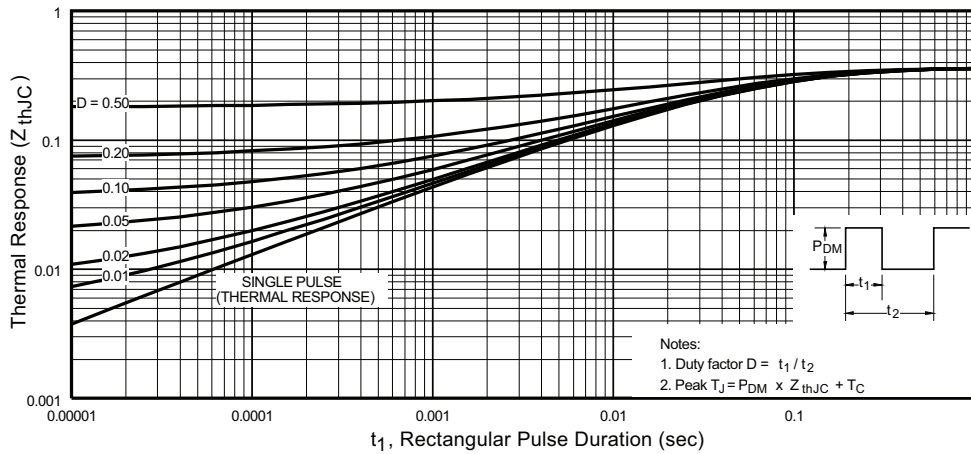


Fig. 5 - Maximum Effective Transient Thermal Impedance, Junction to Case

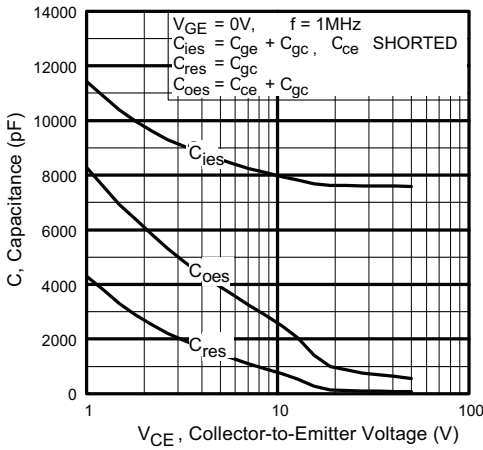


Fig. 6 - Typical Capacitance vs. Collector to Emitter Voltage

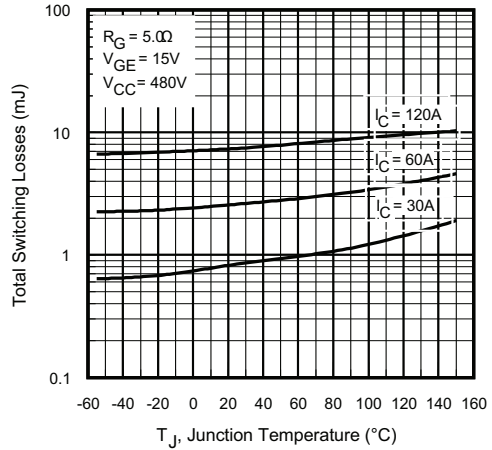


Fig. 9 - Typical Switching Losses vs. Junction Temperature

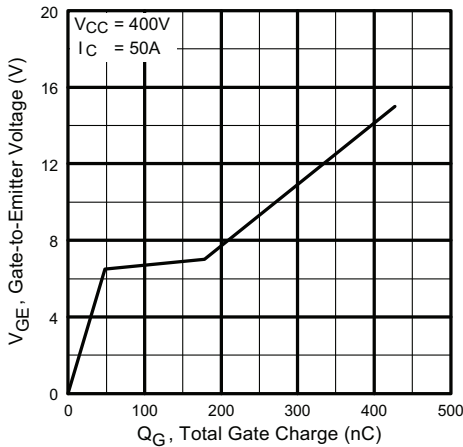


Fig. 7 - Typical Gate Charge vs. Gate to Emitter Voltage

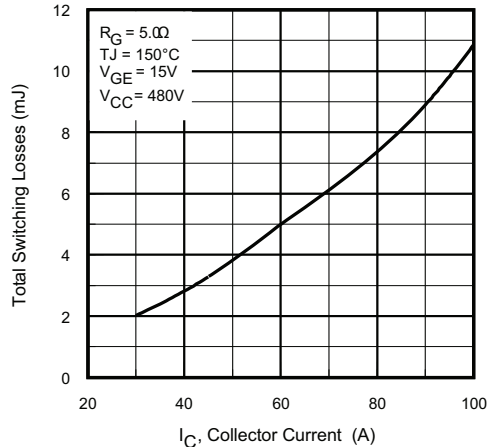


Fig. 10 - Typical Switching Losses vs. Collector to Emitter Current

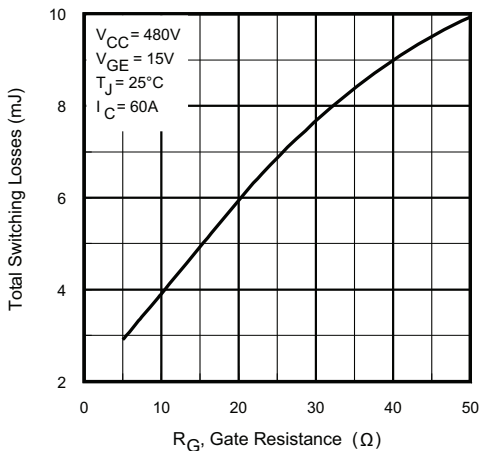


Fig. 8 - Typical Switching Losses vs. Gate Resistance

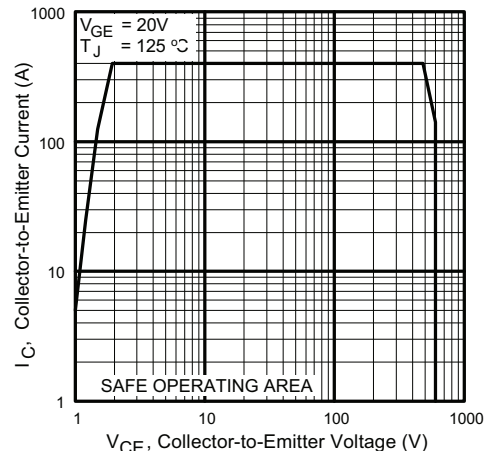


Fig. 11 - Turn-Off SOA

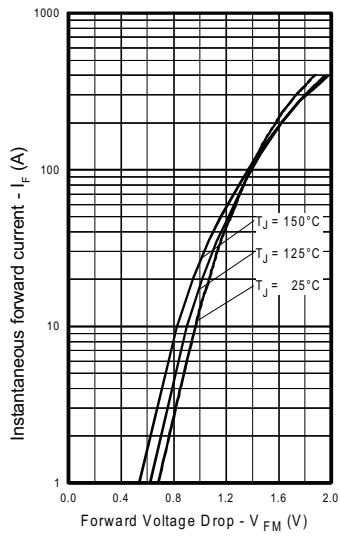


Fig. 12 - Typical Forward Voltage Drop vs. Instantaneous Forward Current

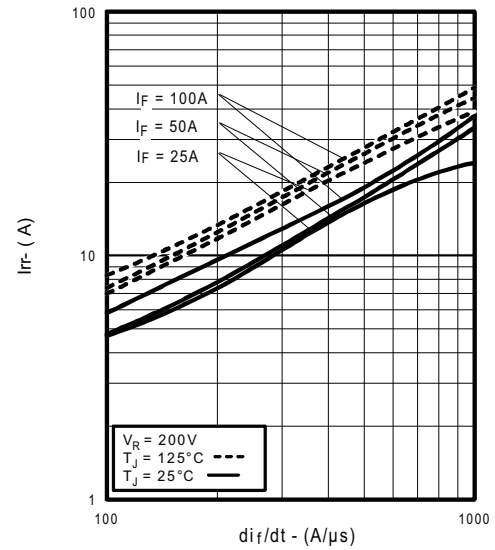


Fig. 14 - Typical Recovery Current vs.  $di_f/dt$

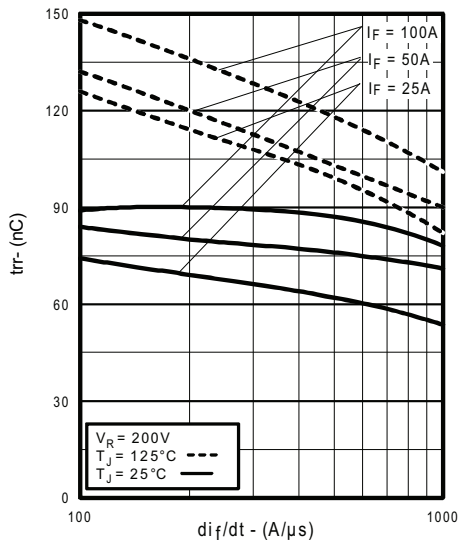


Fig. 13 - Typical Reverse Recovery vs.  $di_f/dt$

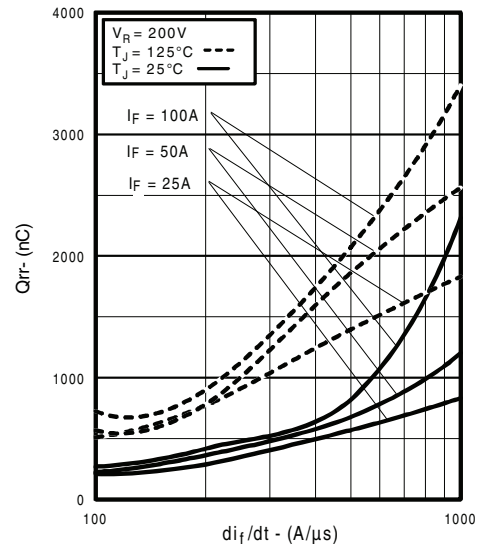


Fig. 15 - Typical Stored Charge vs.  $di_f/dt$

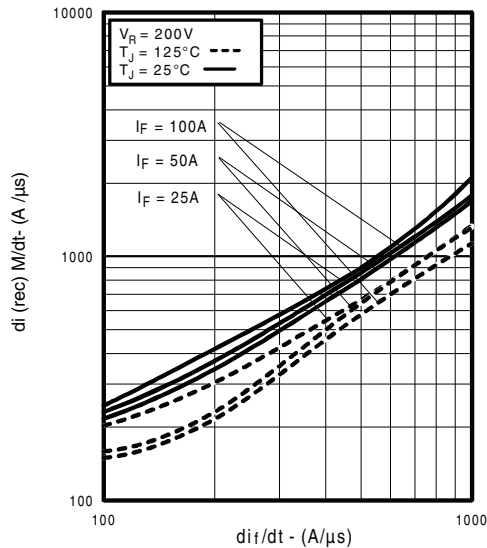


Fig. 16 - Typical  $dI_{(rec)M}/dt$  vs.  $dI_F/dt$

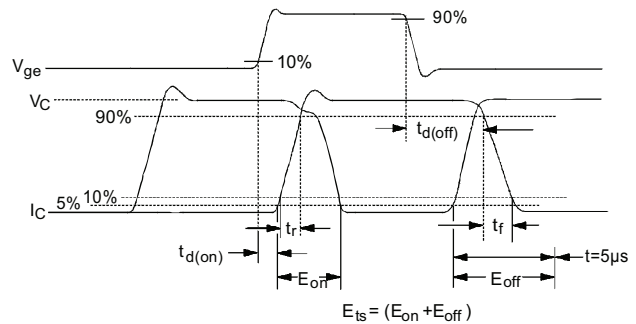


Fig. 17b - Test Waveforms for Circuit of Fig. 17a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$

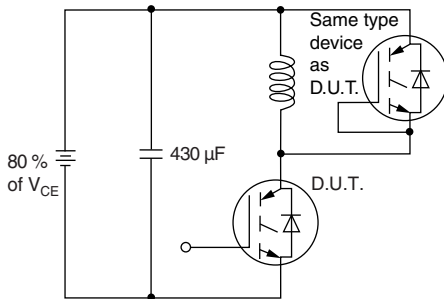


Fig. 17a - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$

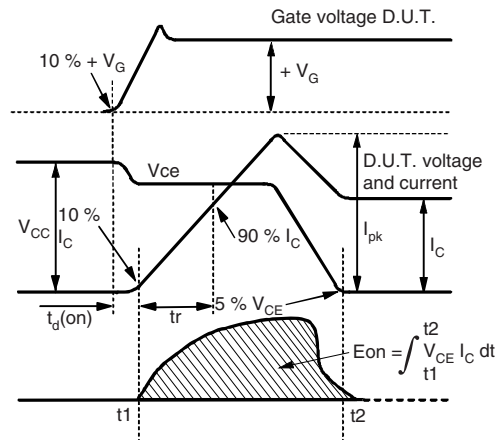


Fig. 17c - Test Waveforms for Circuit of Fig. 17a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$

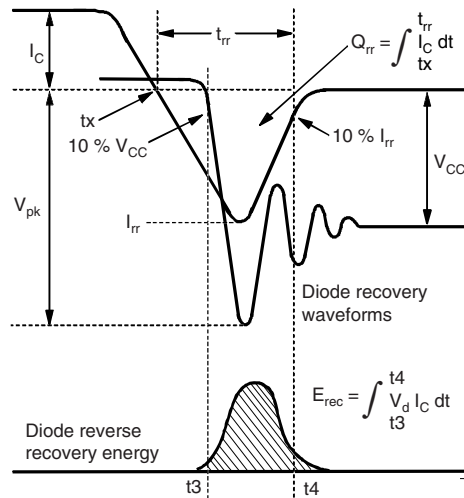
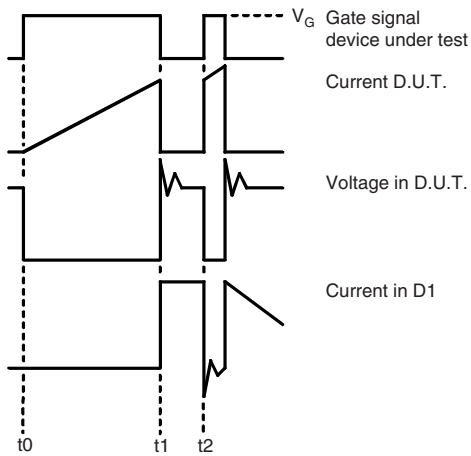

 Fig. 17d - Test Waveforms for Circuit of Fig. 17a,  
 Defining  $E_{rec}$ ,  $t_{tr}$ ,  $Q_{rr}$ ,  $I_{rr}$ 


Fig. 17e - Macro Waveforms for Figure 17a's Test Circuit

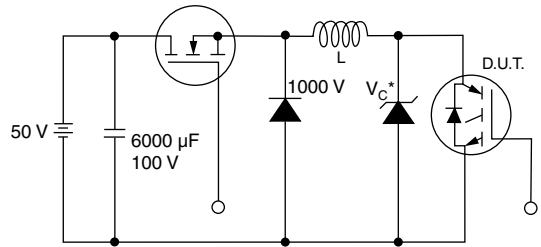


Fig. 18a - Clamped Inductive Load Test Circuit

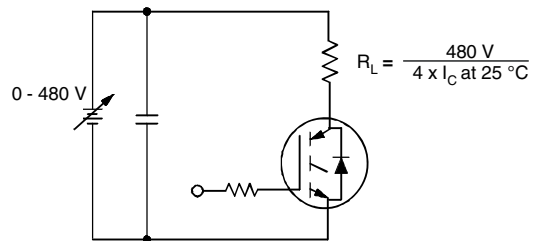


Fig. 18b - Pulsed Collector Current Test Circuit

# GA100NA60UP

Vishay Semiconductors

Insulated Gate Bipolar Transistor  
(Warp 2 Speed IGBT), 100 A

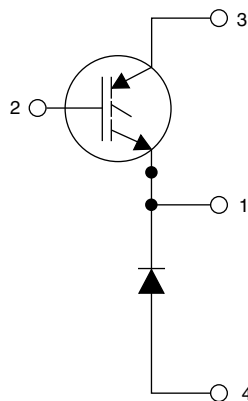


## ORDERING INFORMATION TABLE

Device code	<b>G</b>	<b>A</b>	<b>100</b>	<b>N</b>	<b>A</b>	<b>60</b>	<b>U</b>	<b>P</b>
	①	②	③	④	⑤	⑥	⑦	⑧

- 1** - Device:  
G = IGBT
- 2** - Silicon technology:  
A = Generation 4 IGBT, Generation 2 HEXFRED®
- 3** - Current rating (100 = 100 A)
- 4** - N = High side chopper
- 5** - SOT-227
- 6** - Voltage rating (60 = 600 V)
- 7** - U = Ultrafast with matching diode
- 8** -
  - None = Standard production
  - P = Lead (Pb)-free

## CIRCUIT CONFIGURATION

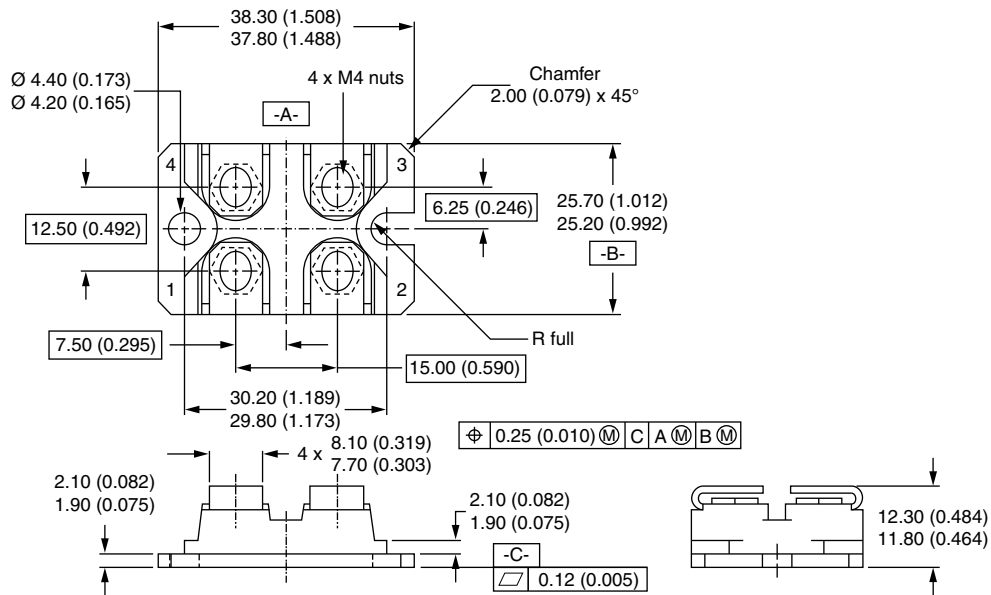


LINKS TO RELATED DOCUMENTS	
Dimensions	<a href="http://www.vishay.com/doc?95036">www.vishay.com/doc?95036</a>
Packaging information	<a href="http://www.vishay.com/doc?95037">www.vishay.com/doc?95037</a>



## SOT-227

**DIMENSIONS** in millimeters (inches)



### Notes

- Dimensioning and tolerancing per ANSI Y14.5M-1982
- Controlling dimension: millimeter



## Disclaimer

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